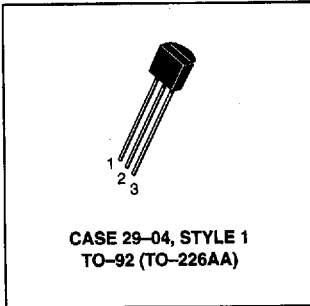
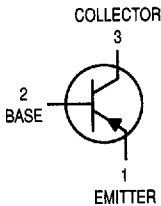


**Amplifier Transistor**  
PNP Silicon

**MPSL51**



**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CEO</sub>	-100	Vdc
Collector-Base Voltage	V <sub>CB0</sub>	-100	Vdc
Emitter-Base Voltage	V <sub>EBO</sub>	-4.0	Vdc
Collector Current — Continuous	I <sub>C</sub>	-600	mAdc
Total Device Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	625 5.0	mW mW/°C
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	1.5 12	Watts mW/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

**THERMAL CHARACTERISTICS**

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	R <sub>θJA</sub>	200	°C/W
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	83.3	°C/W

**ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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**OFF CHARACTERISTICS**

Collector-Emitter Breakdown Voltage <sup>(1)</sup> (I <sub>C</sub> = -1.0 mAdc, I <sub>B</sub> = 0)	V <sub>(BR)CEO</sub>	-100	—	Vdc
Collector-Base Breakdown Voltage (I <sub>C</sub> = -100 μAdc, I <sub>E</sub> = 0)	V <sub>(BR)CBO</sub>	-100	—	Vdc
Emitter-Base Breakdown Voltage (I <sub>E</sub> = -10 μAdc, I <sub>C</sub> = 0)	V <sub>(BR)EBO</sub>	-4.0	—	Vdc
Collector Cutoff Current (V <sub>CB</sub> = -50 Vdc, I <sub>E</sub> = 0)	I <sub>CBO</sub>	—	-1.0	μAdc
Emitter Cutoff Current (V <sub>EB</sub> = -3.0 Vdc, I <sub>C</sub> = 0)	I <sub>EBO</sub>	—	-100	nAdc

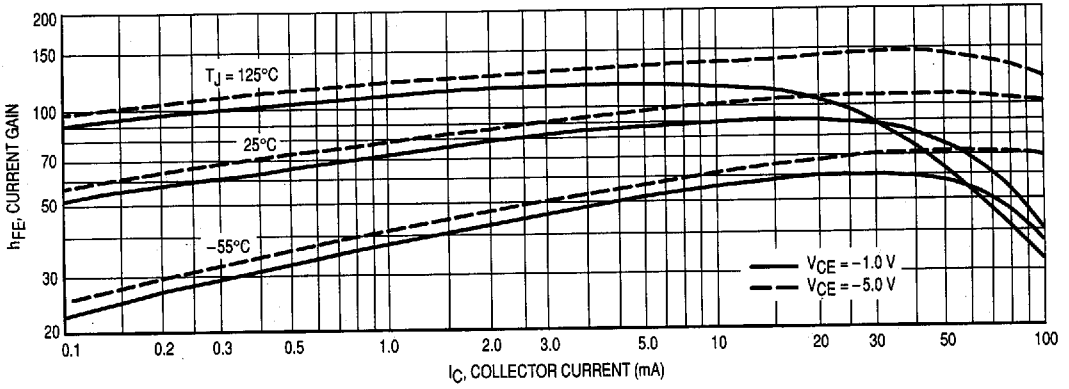
1. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2.0%.

6367255 0093449 375

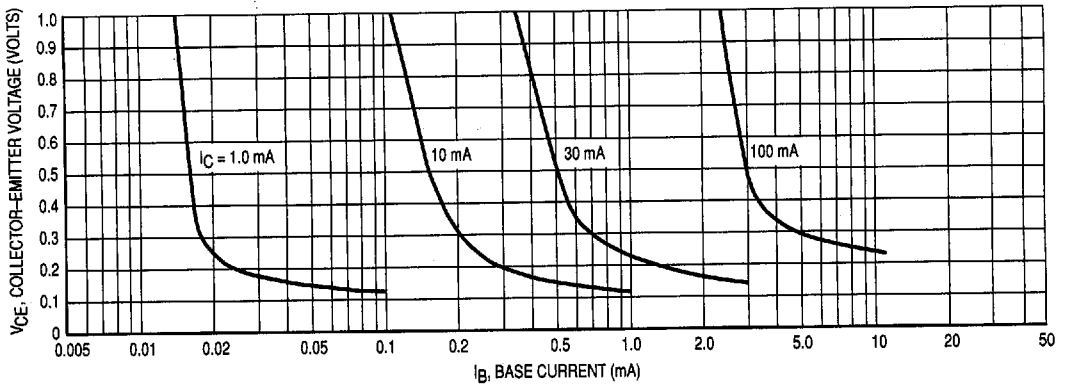
ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (Continued)

Characteristic	Symbol	Min	Max	Unit
<b>ON CHARACTERISTICS(1)</b>				
DC Current Gain <sup>(1)</sup> ( $I_C = -50 \text{ mAdc}$ , $V_{CE} = -5.0 \text{ Vdc}$ )	$h_{FE}$	40	250	—
Collector-Emitter Saturation Voltage ( $I_C = -10 \text{ mAdc}$ , $I_B = -1.0 \text{ mAdc}$ ) ( $I_C = -50 \text{ mAdc}$ , $I_B = -5.0 \text{ mAdc}$ )	$V_{CE(sat)}$	—	-0.25 -0.30	Vdc
Base-Emitter Saturation Voltage ( $I_C = -10 \text{ mAdc}$ , $I_B = -1.0 \text{ mAdc}$ ) ( $I_C = -50 \text{ mAdc}$ , $I_B = -5.0 \text{ mAdc}$ )	$V_{BE(sat)}$	—	-1.2 -1.2	Vdc
<b>SMALL-SIGNAL CHARACTERISTICS</b>				
Current-Gain — Bandwidth Product ( $I_C = -10 \text{ mAdc}$ , $V_{CE} = -10 \text{ Vdc}$ , $f = 20 \text{ MHz}$ )	$f_T$	60	—	MHz
Output Capacitance ( $V_{CB} = -10 \text{ Vdc}$ , $I_E = 0$ , $f = 1.0 \text{ MHz}$ )	$C_{obo}$	—	8.0	pF
Small-Signal Current Gain ( $I_C = -1.0 \text{ mAdc}$ , $V_{CE} = -10 \text{ Vdc}$ , $f = 1.0 \text{ kHz}$ )	$h_{fe}$	20	—	—

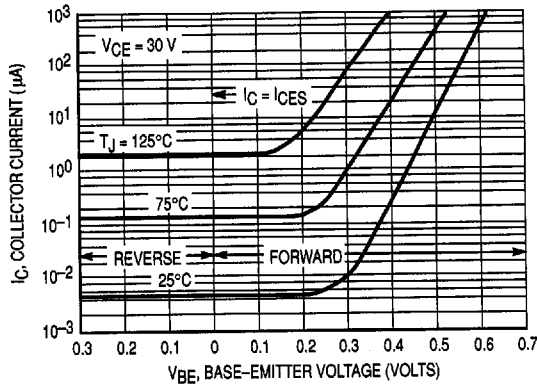
1. Pulse Test: Pulse Width = 300  $\mu\text{s}$ , Duty Cycle = 2.0%.



**Figure 1. DC Current Gain**



**Figure 2. Collector Saturation Region**



**Figure 3. Collector Cut-Off Region**

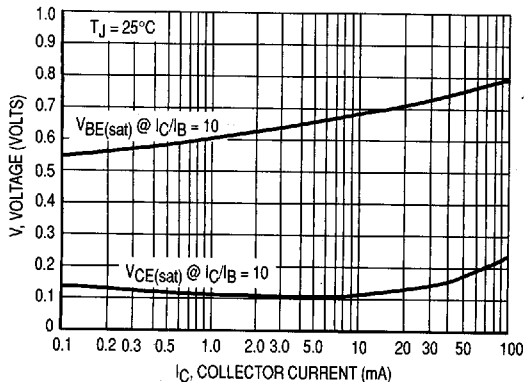


Figure 4. "On" Voltages

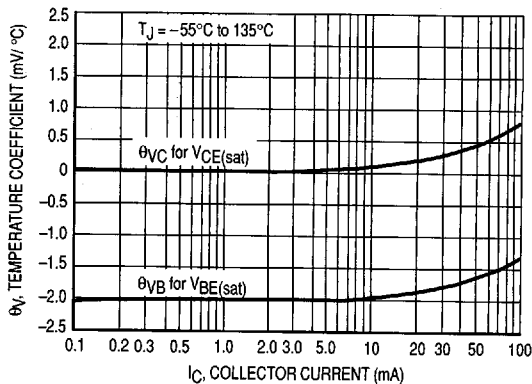
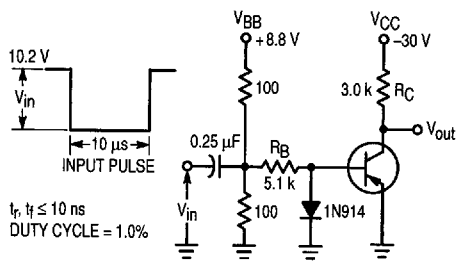


Figure 5. Temperature Coefficients



Values Shown are for  $I_C @ 10 \text{ mA}$

Figure 6. Switching Time Test Circuit

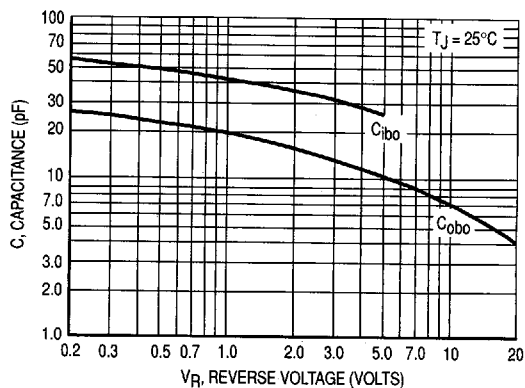


Figure 7. Capacitances

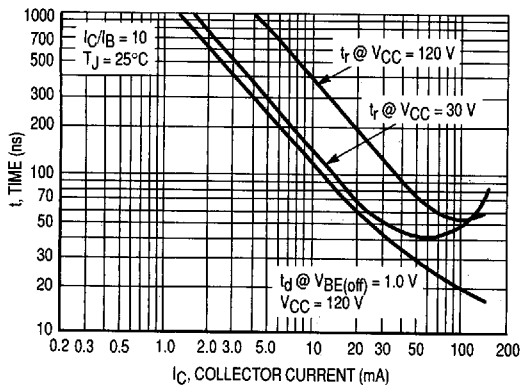


Figure 8. Turn-On Time

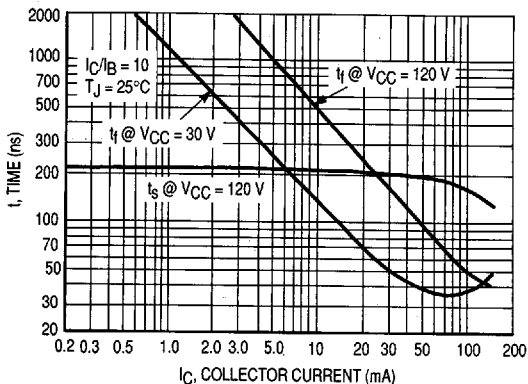


Figure 9. Turn-Off Time

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